	Search Notes
t 199191 (1919 801); t 19807 (1162 1919 11919 11959 (1911 180)	

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/739,222	YOSHIMURA ET AL.	
Examiner	Art Unit	
TAN Q. NGUYEN	3661	

	SEARCHED				
Class	Subclass	Date	Examiner		
701	1,54	6/20/2007	TN		
•					

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	-			
	T	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		,
-		